

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 108455		APPLICATION NO. NEW US PATENT APPLICATION	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANTS Yasuhiro OMURA, Naomasa SHIRAISHI and Soichi OWA			
FILING DATE January 26, 2001				2851			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
P2		09/260544	03/02/1999	Ebiarra et al.	/	/	
P2		09/340,236	07/01/1999	Komatsuda	/	/	
P2		09/661,396	03/26/1999	Irie	/	/	
P2		5,473,410	12/05/1995	Nishi	/	/	
P1		5,576,895	11/19/1996	Ikeda	/	/	
P2		5,636,066	06/03/1997	Takahashi	/	/	
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P2		5,850,300	12/15/1998	Kathman et al.	/	/	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
P2		EP 0 855 623 A2	07/29/1998	Europe	/	/	
P2		EP 0 951 054 A1	10/20/1999	Europe	/	/	
P2		EP 1 020 897 A1	07/19/2000	Europe	/	/	
P2		EP 1 030 351 A1	08/23/2000	Europe	/	/	
P2		EP 1 043 625 A1	10/11/2000	Europe	/	/	
P2		EP 1 069 600 A1	01/17/2001	Europe	/	/	
P2		GB 2 290 658 A	01/03/1996	Great Britain	/	/	
P2		WO 98/28665	07/02/1998	WIPO	/	/	
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		WO 99/25010 ✓	05/20/1999	WIPO	/	/	
		WO 99/34255 ✓	07/08/1999	WIPO	/	/	
EXAMINER					DATE CONSIDERED		
					12-15-02		
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Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 108455		APPLICATION NO. NEW US PATENT APPLICATION  09/769,832	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANTS Yasuhiro OMURA, Naomasa SHIRAISHI and Soichi OWA			
				FILING DATE January 26, 2001			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
		WO 99/49505 ✓	09/30/1999	WIPO	—	—	
		WO 99/50712 ✓	10/07/1999	WIPO	—	—	
		WO 99/66370 ✓	12/23/1999	WIPO	—	—	
		JP A 4-196513 ✓	07/16/1992	Japan	—	—	
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		JP A 10-163097 ✓	06/19/1998	Japan	—	—	
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		JP A 10-214783 ✓	08/11/1998	Japan	—	—	
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		JP A 11-194479 ✓	07/21/1999	Japan	—	—	
		JP A 11-219902 ✓	08/10/1999	Japan	—	—	
		JP A 11-231192 ✓	08/27/1999	Japan	—	—	
		JP A 11-251217 ✓	09/17/1999	Japan	—	—	
		JP A 2000-12453 ✓	01/14/2000	Japan	—	—	
		JP A 2000-21765 ✓	01/21/2000	Japan	—	—	
		JP A 2000-28898 ✓	01/28/2000	Japan	—	—	
		JP A 2000-29202 ✓	01/28/2000	Japan	—	—	
EXAMINER <i>R. J. [Signature]</i>					DATE CONSIDERED 12-15-02		
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## INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)  
Yasuhiro OMURA et al.FILING DATE  
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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
P2	5,140,459	08/1992	SAGAN	359	434

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
JP-A-9-312254 w/ English-language Abstracts	12/1997	JAPAN	—	—

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)


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EXAMINER

R. S. Lee

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Date: September 24, 2002